Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/684,188	FUJII ET AL.	
Examiner	Art Unit	
Drew J. Brown	3616	

	SEAR	CHED	
Class	Subclass	Date	Examiner
280	728.3	8/18/2005	DB
280	732	8/18/2005	DB
Updated		1/23/2006	DB
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INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
	-		

(INCLUDING SE	CH NOTES ARCH STRATEGY)
	DATE	EXMR
David Dunn	8/18/2005	DB
See Attachment	8/18/2005	DB